

December 2013

IRL640A

N-Channel Logic Level A-FET 200 V, 18 A, 180 m Ω

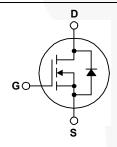
Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar, DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switching DC/DC converters, switch mode power supplies, DC-AC converters for uninterrupted power supply and motor control.

Features

- 18 A, 200 V, $R_{DS(on)}$ = 180 m Ω @ V_{GS} = 5 V
- Low Gate Charge (Typ. 40 nC)
- Low Crss (Typ. 95 pF)
- · Fast Switching
- 100% Avalanche Tested
- Improved dv/dt Capability
- · Logic-Level Gate Drive





Absolute Maximum Ratings

Symbol	Characteristic	Value	Units	
$V_{\rm DSS}$	Drain-to-Source Voltage	200	V	
	Continuous Drain Current (T _C =25°C)	18		
I _D	Continuous Drain Current (T _C =100°C)	11.4	A	
I _{DM}	Drain Current-Pulsed (1)	63	Α	
V_{GS}	Gate-to-Source Voltage	±20	V	
E _{AS}	Single Pulsed Avalanche Energy (2)	64	mJ	
I _{AR}	Avalanche Current (1)	18	Α	
E _{AR}	Repetitive Avalanche Energy (1)	11	mJ	
dv/dt	Peak Diode Recovery dv/dt (3)	5	V/ns	
	Total Power Dissipation (T _C =25°C)	110	W	
P_{D}	Linear Derating Factor	0.88	W/°C	
T T	Operating Junction and	55 (450		
T_J , T_STG	Storage Temperature Range	- 55 to +150		
-	Maximum Lead Temp. for Soldering	000	°C	
T_L	Purposes, 1/8. from case for 5-seconds	300		

Thermal Resistance

Symbol	Characteristic	Тур.	Max.	Units
$R_{ heta JC}$	Junction-to-Case		1.14	
$R_{\theta CS}$	Case-to-Sink	0.5		°C/W
$R_{\theta JA}$	Junction-to-Ambient		62.5	

Package Marking and Ordering Information

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
IRL640A	IRL640A	TO-220	Tube	N/A	N/A	50 units

Electrical Characteristics ($T_{\rm C}$ =25 $^{\circ}{\rm C}$ unless otherwise specified)

Symbol	Characteristic	Min.	Тур.	Max.	Units	Test Condition	
BV _{DSS}	Drain-Source Breakdown Voltage	200			V	$V_{GS} = 0V, I_{D} = 250 \mu A$	
$\Delta BV/\Delta T_J$	Breakdown Voltage Temp. Coeff.		0.17		V/°C	I _D =250μA	
$V_{GS(th)}$	Gate Threshold Voltage	1.0		2.0	V	$V_{DS} = 5V, I_{D} = 250 \mu A$	
ı	Gate-Source Leakage, Forward			100	nA	V _{GS} =20V	
I _{GSS}	Gate-Source Leakage, Reverse			-100	ПА	V _{GS} =-20V	
	Dunin to Course I column Cumant			10		V _{DS} =200V	
I _{DSS}	Drain-to-Source Leakage Current		-	100	μΑ	V _{DS} =160V,T _C =125°C	
B	Static Drain-Source					V 5VI 0A (4)	
R _{DS(on)}	On-State Resistance			0.18	Ω	$V_{GS}=5V,I_{D}=9A \qquad (4)$	
g _{fs}	Forward Transconductance		13.3		Ω	$V_{DS} = 40V, I_{D} = 9A$ (4)	
C _{iss}	Input Capacitance		1310	1705		\\ 0\\\\ 25\\\$ 4MH=	
C _{oss}	Output Capacitance		200	250	рF	V _{GS} =0V,V _{DS} =25V,f =1MHz See Fig 5	
C _{rss}	Reverse Transfer Capacitance		95	120			
t _{d(on)}	Turn-On Delay Time		11	30		V 400VI 40A	
t _r	Rise Time		8	25		$V_{DD} = 100 V, I_{D} = 18 A,$	
t _{d(off)}	Turn-Off Delay Time		46	100	ns	$R_G=4.6\Omega$	
t _f	Fall Time		15	40		See Fig 13 (4) (5)	
Q_g	Total Gate Charge		40	56		$V_{DS} = 160 V, V_{GS} = 5 V,$	
Q_gs	Gate-Source Charge		6.8		nC	I _D =18A	
Q_{gd}	Gate-Drain (. Miller.) Charge		18.6			See Fig 6 & Fig 12 (4) (5)	

Source-Drain Diode Ratings and Characteristics

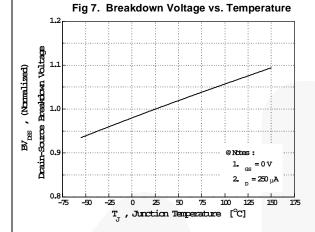
Symbol	Characteristic	Min.	Тур.	Max.	Units	Test Condition
Is	Continuous Source Current	1		18	_	Integral reverse pn-diode
I _{SM}	Pulsed-Source Current (1)	1		63	Α	in the MOSFET
V_{SD}	Diode Forward Voltage (4)	1		1.5	V	T _J =25°C,I _S =18A,V _{GS} =0V
t _{rr}	Reverse Recovery Time		224		ns	T _J =25°C,I _F =18A
Q _{rr}	Reverse Recovery Charge		1.55		μС	$di_F/dt=100A/\mu s$ (4)

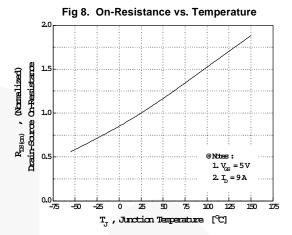
Notes:

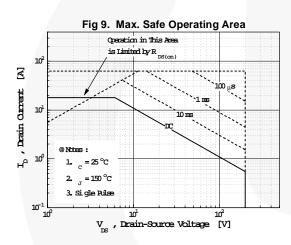
- (1) Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
- (2) L=0.3mH, I_{AS}=18A, V_{DD}=50V, R_G=27 Ω , Starting T_J=25°C
- (3) $I_{SD} \le 18A$, $di/dt \le 260A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$ (4) Pulse Test: Pulse Width = 250 μs , Duty Cycle $\le 2\%$
- (5) Essentially Independent of Operating Temperature

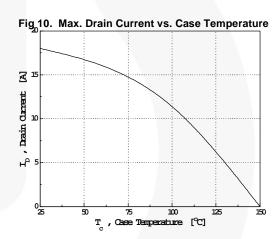
Typical Characteristics Fig 1. Output Characteristics Fig 2. Transfer Characteristics V_{GS} Top: 60 V 55 V ₹ Ξ 10¹ 45V 40V Ip , Drain Current 10¹ Drain Current 35 V Bottom: 3.0 V 100 1. $_{\rm GS}$ = 0 V _{DS} = 40 V 2. 1. 25 μs Pulse c = 25 °C 10⁻¹ 10⁻¹ 10° 10¹ V Drain-Source Voltage [V] V_{GS} , Gatte-Source Voltage [V] Fig 3. On-Resistance vs. Drain Current Fig 4. Source-Drain Diode Forward Voltage ₹ In , Reverse Drain Current Drain-Source On-Resistance 10¹ $R_{be(cm)}$, [Ω] 0.1 1. _{GS} = 0 V @Note: $T_{_{\!\mathcal{I}}} = 25\,^{\circ}\mathrm{C}$ 2. 25 μ s Rulse Test 0.0 10 I , Drain Current [A] 0.4 1.0 1.2 1.4 1.6 V_{SD} , Source-Drain Voltage [V] Fig 5. Capacitance vs. Drain-Source Voltage Fig 6. Gate Charge vs. Gate-Source Voltage C_{iss}=C_{gs}+C_{gd} (C_{ds}=shorted) $C_{oss} = C_{ds} + C_{gd}$ Crss=Cgd $V_{DS} = 40 \text{ V}$ Σ $V_{DS} = 100 \text{ V}$ ď $V_{\rm GB}$, Gatte-Source Voltage V_{DS} = 160 V Capacitance @ Notes: 1. $V_{GS} = 0 \text{ V}$ 2. f = 1 MHz 0L 20 30 40 Q, , Total Gate Charge [nC] V_{DS} , Drain-Source Voltage [V]

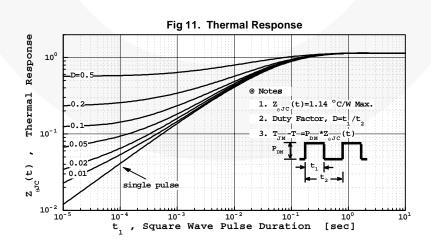
Typical Characteristics (continued)











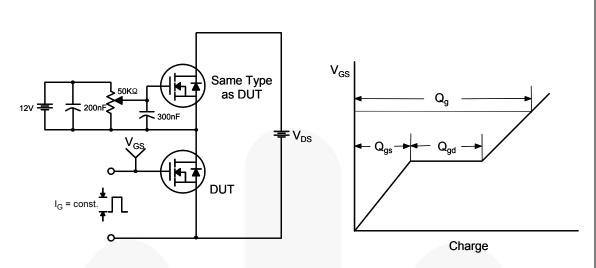


Figure 12. Gate Charge Test Circuit & Waveform

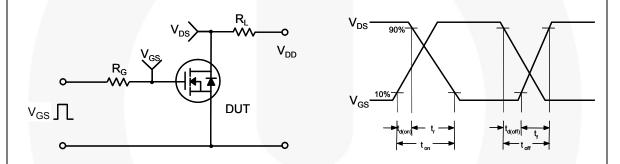


Figure 13. Resistive Switching Test Circuit & Waveforms

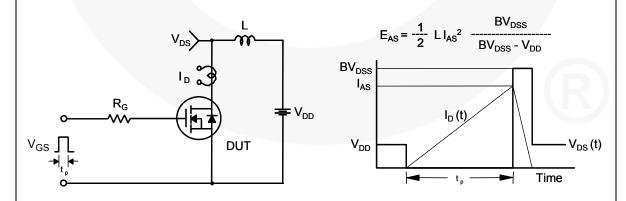
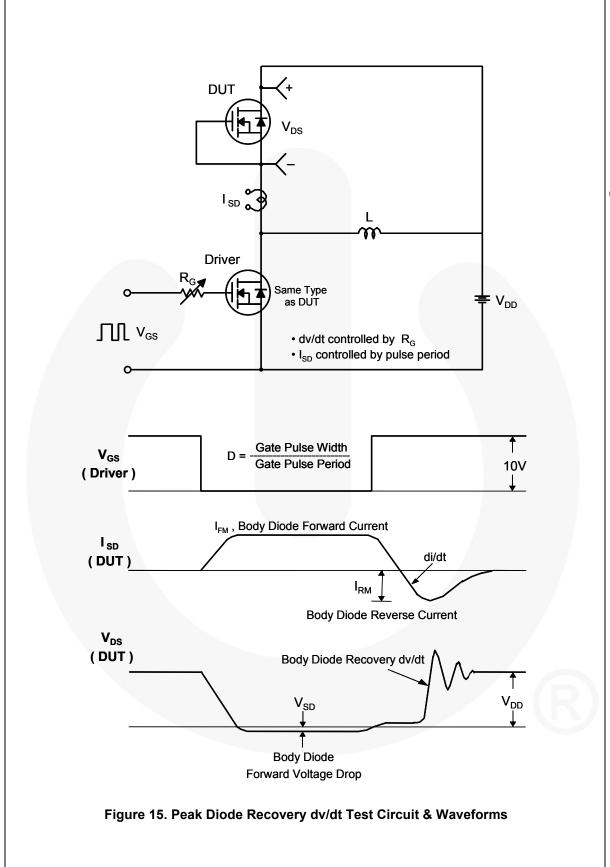


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



Mechanical Dimensions

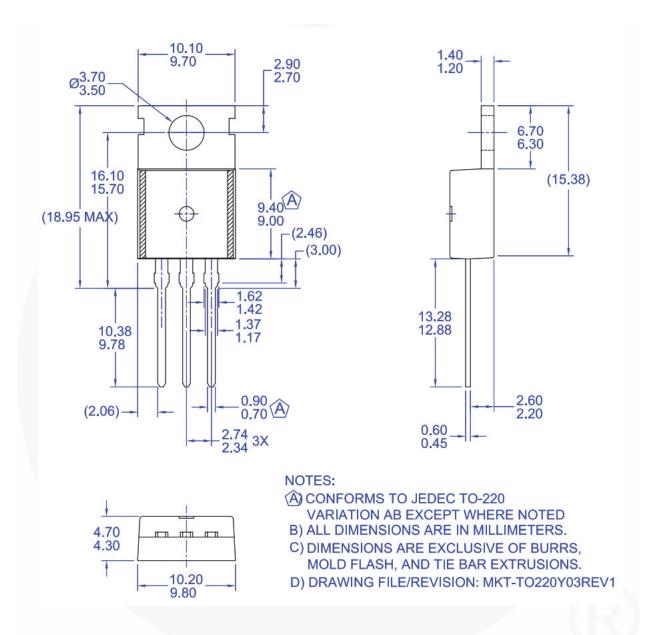


Figure 16. TO220, Molded, 3-Lead, Jedec Variation AB

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